Exploiting Count Spectra for Bayesian Fault Localization

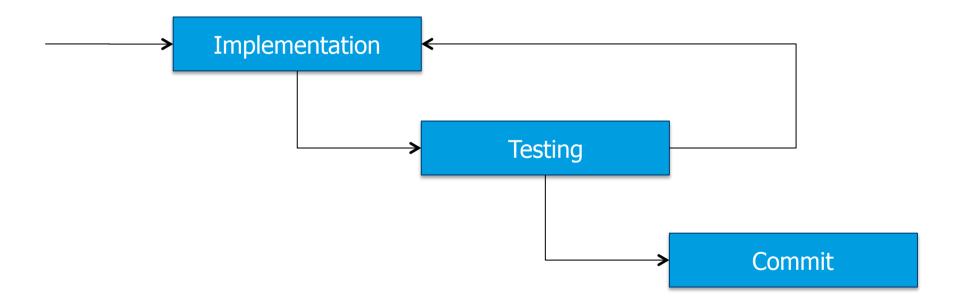
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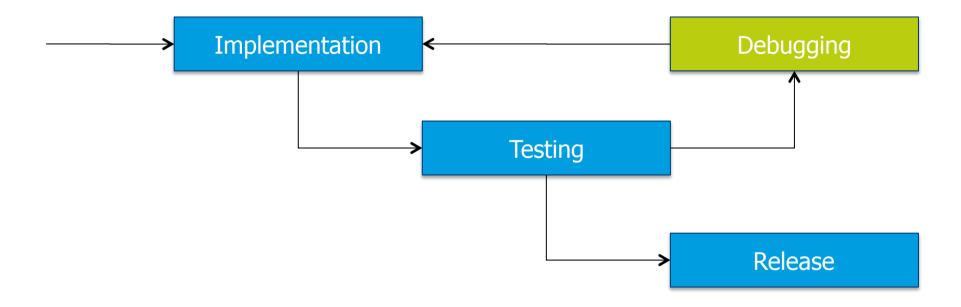
(Simplified) Software Lifecyle







(Simplified) Software Lifecyle





Preliminaries

- Diagnostic system DS = <SD, COMPS, OBS>
 - SD, system description (propositional theory)
 - COMPS = $\{c_1,...,c_M\}$
 - OBS, set of observable variables
- Each component c_i has a health variable h_i
 - ∀j: h_j => inp_ok_j => out_ok_j
- A failed test is an observation obs
- Diagnostic candidates d_k that explain the observations
 - Defining the states of the variables h_i
- Diagnostic ranking $D = \{d_1, ..., d_k, ..., d_K\}$



System and Observation Model

$$h_1 \Rightarrow (x_1 \Rightarrow y_1)$$

$$h_2 \Rightarrow (x_2 \Rightarrow y_2)$$

$$h_3 \Rightarrow (x_3 \Rightarrow y_3)$$

$$h_4 \Rightarrow (x_4 \Rightarrow y_4)$$

$$h_5 \Rightarrow (x_5 \Rightarrow y_5)$$

$$x_5 = y_4$$

$$x_4 = y_3$$

$$x_3 = y_2$$

$$x_2 = y_1$$

$$x_1 = \text{true}$$

$$y_4 = \neg e_n$$

$$\rightarrow 1 \rightarrow 2 \rightarrow 3 \rightarrow 4 \rightarrow 5 \rightarrow$$

$$h_1 \wedge h_2 \wedge h_3 \wedge h_4 \wedge h_5 \Rightarrow false$$

$$\neg h_1 \vee \neg h_2 \vee \neg h_3 \vee \neg h_4 \vee \neg h_5$$
 (conflict)

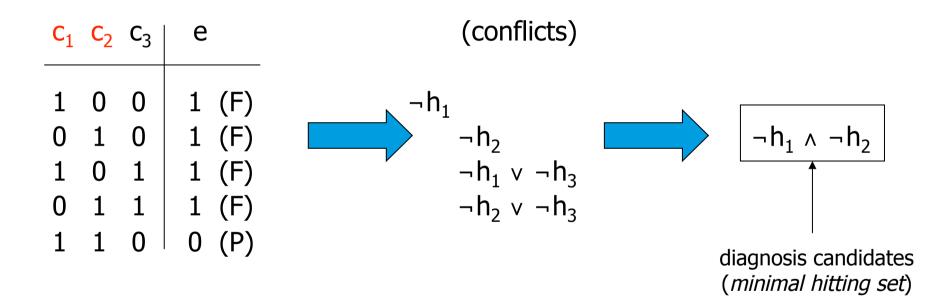
Spectrum-based Reasoning

$$N \text{ spectra} \begin{bmatrix} a_{11} & a_{12} & \dots & a_{1M} \\ a_{21} & a_{22} & \dots & a_{2M} \\ \vdots & \vdots & \ddots & \vdots \\ a_{N1} & a_{N2} & \dots & a_{NM} \end{bmatrix} \begin{bmatrix} e_1 \\ e_2 \\ \vdots \\ e_N \end{bmatrix}$$

Figure 1: Input for SFL



Spectrum-based Reasoning



1 diagnosis candidate $\{c_1,c_2\} =>$ correct diagnosis

Candidate Ranking

Probabilities updated according to Bayes' rule

$$\Pr(d_k|obs) = \frac{\Pr(obs|d_k)}{\Pr(obs)} \cdot \Pr(d_k)$$

where

$$\Pr(obs|d_k) = \begin{cases} 0 & \text{if } d_k \text{ and } obs \text{ are inconsistent} \\ 1 & \text{if } d_k \text{ logically follows from } obs \\ \varepsilon & \text{if neither holds} \end{cases}$$

Candidate Ranking

• One of the best ε for software fault localization (ASE'09)

$$\varepsilon = \begin{cases} g(d_k)^{\eta} & \text{if run passed} \\ 1 - g(d_k)^{\eta} & \text{if run failed} \end{cases}$$

Where

$$g(d_k) = \frac{\sum_{n=1..N} \left[\left(\bigvee_{j \in d_k} a_{nj} \neq 0 \right) \land e_n = 0 \right]}{\sum_{n=1..N} \left[\bigvee_{j \in d_k} a_{nj} \neq 0 \right]}$$

Example

```
/* block 0: main */
void RationalSort(int n, int *num, int *den) {
  /* block 1 */
  int i, j, temp;
  for ( i=n-1; i>=0; i-- ) {
    /* block 2 */
    for ( j=0; j<i; j++ ) {</pre>
      /* block 3 */
      if (RationalGT(num[j], den[j], num[j+1], den[j+1])) {
        /* block 4 */
        temp = num[j]; num[j] = num[j+1]; num[j+1] = temp;
```



Example (good)

		block					
Т	0	1	2	3	4	5	e
1	1	1	1	1	0	1	0
2	1	1	1	1	1	1	1

#	d _k	Pr(d _k)
1	{4}	0.44
2	{1}	0.11
2	{2}	0.11
2	{3}	0.11
2	{0}	0.11
2	{5}	0.11



Example (bad)

		block					
Т	0	1	2	3	4	5	e
1	1	1	1	1	1	1	0
2	1	1	1	1	1	1	1

#	d _k	Pr(d _k)
1	{0}	0.16
1	{1}	0.16
1	{2}	0.16
1	{3}	0.16
1	{0}	0.16
1	{4}	0.16



Count Spectra as Tie-breaker

		block					
Т	0	1	2	3	4	5	е
1	1	1	4	6	3	6	0
2	1	1	4	6	5	6	1





Zoltar-C

		block					
Т	0	1	2	3	4	5	е
1	1	1	4	6	3	6	0
2	1	1	4	6	5	6	1

$$\varepsilon = \begin{cases} g(d_k)^t & \text{if } e_i = 0\\ 1 - g(d_k)^t & \text{if } e_i = 1 \end{cases}$$

$$t = \sum_{j \in d_k} a_{ij}.$$

#	d _k	Pr(d _k)
1	{0}	0.27
2	{1}	0.21
2	{2}	0.21
2	{3}	0.19
2	{0}	0.07
2	{4}	0.07



Evaluation

- Real-world software programs
 - Software infrastructure repository
 - O(10) faulty versions
 - O(100) LOC, O(1000) test cases
 - 1, 2, 5 faults
- Programs have been modified to accommodate multiple faults

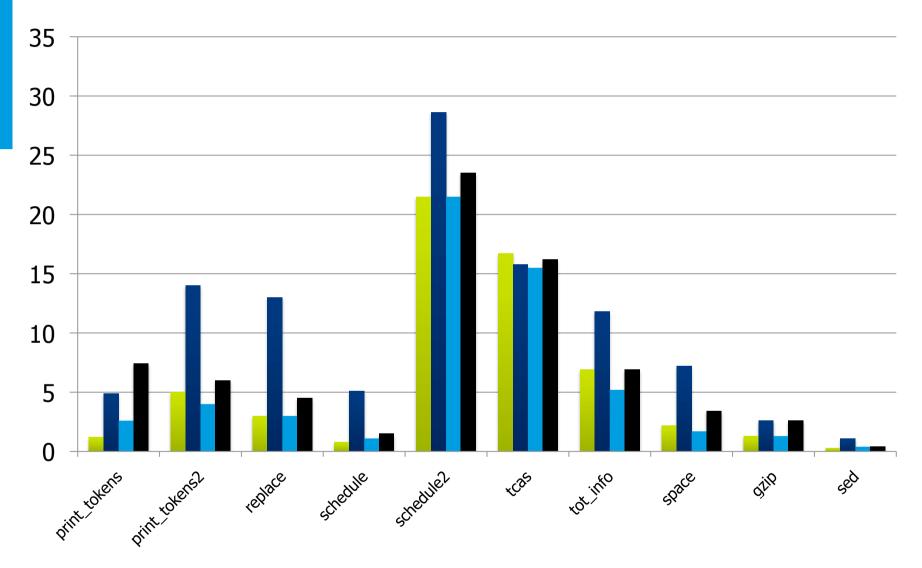


Evaluation Metric - W

- Excess work incurred in finding the faulty components
- Independent of number of faults
- As an example, suppose
 - A M=10-component program, where c_1 and c_2 are faulty
 - D = <{1,3}, {3,5}, {2,4}>
 - Inspecting order: 1,3,4,2
 - W = 2/(10-2)









Fail 🕾

- Unrealistic assumption:
 - Bit-spectra work because observations are independent
 - Each "cover" in the count is NOT independent
- g(d_k) is calculated on a bit fashion
- Pass/fail of test cases sample is highly biased in siemens
- tcas works because most of the times the count is 0-1



Conclusions

- Current spectrum-based approaches only exploit component involvement, which leads to ties
- Zoltar-C: tie-breaking by exploiting count spectra
- Zoltar-C does not improve the diagnostic process
 - Assumes (unrealistic) or-model
 - Highly biased sample of pass/fail test cases



Future Work

- Theoretically study the performance of count spectra
- Study the performance impact of the (more/less) number of runs
- Predict number of faults in system





Co-located with ICST

Deadline December 20th

http://paginas.fe.up.pt/~tebug2011/

Mulţumesc!

